

Embedded Flash Memory

Consumer & Industrial Solutions

SLC & 3D-TLC

e-MMC & UFS

Automotive Solutions

e-MMC & UFS





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Leading Supplier and Inventor of Flash Memory

Silica wafers are formed from highly pure, nearly defect-free single crystalline material: the starting point for any integrated circuits.

INNOVATION IS OUR TRADITION

In 1984 Toshiba invented a new type of semiconductor memory called flash memory. Later in 1987, NAND flash memory was developed that raised electronic equipment to the next level. The NAND flash market has grown rapidly, with flash memory becoming an internationally standardised memory device. KIOXIA, the inventor of flash memory, has thus carved out a path to a new era in which innovations are increased by the opportunities of NAND flash.

Under its new name, KIOXIA keeps this invention and continues to provide embedded memory solutions. Embedded memory connects us with the things that surround and serve us – for more efficiency, comfort and sustainability.

SPEED UP DIGITAL PROCESSES

Storing and processing data has always been an important aspect of all digital processes. But in the last years it increased to one of the key technologies for industry 4.0, smart mobility, cloud technology and artificial intelligence, because smart ideas and innovations have to be ready for markets right away – with high reliability of storage components.

With our embedded memory solutions, KIOXIA is the partner for all smart markets and fast moving industries. KIOXIA provides a highly grade of innovation combined with highly reliable security – now and in the future.

PARTNERSHIP IS OUR PASSION

Our success is based on our strong customer focus: Your metrics are our metrics. The result is a broad range of industry-leading flash-based storage solutions. Our products are designed to meet your specific engineering demands.

KIOXIA
EMBEDDED MEMORY –
THE KEY TO A
SMART FUTURE

"With progressive memory technology at the core, we offer products, services, and systems that create choice and define the future."





HISTORY AND MISSION

OUR LEGACY OF INNOVATION COMES WITH US



THE INVENTOR OF FLASH MEMORY.

With our proven track record of success and reputation for innovation, KIOXIA will build on our history as we continue our journey as an independent company...

Invented NAND flash memory memory

Started mass production of NAND flash

Announced 3D flash memory technology

World's first 24 nm SLC NAND NAND flash flash memory

World's first 15 nm 128 Gbit memory

Started mass production of 48-layer BiCS FLASH™

Prototyped QLC BiCS FLASH™ memory

Started mass production of 96-layer BiCS FLASH™

KIOXIA Est. Oct 2019

Announced 162-layer BiCS FLASH™

218-layer BiCS FLASH™

1987

1991 1992

2007

2011

2014

2016

2017

2018

2019

2021

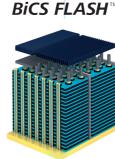
2022

2023

Yokkaichi Plant established

Completed Yokkaichi Plant Fab 5 construction

Completed Yokkaichi Plant new Fab 2 construction



Completed

Yokkaichi Plant Fab 6 construction Completed Kitakami Plant K1 construction

Yokkaichi Plant Y7 construction started

Completed first phase of Yokkaichi Plant new Fab 7 construction Started construction of Kitakami Plant K2

INNOVATIVE. AWARD-WINNING. TRUSTED.

Memory Solutions

Extensive product lineup

Excellent reliability & quality

Leading density & capacity





SSD **Solutions**

In-house SoC & firmware

Latest interfaces & form factors

Broad portfolio of SSDs

07 EMBEDDED FLASH MEMORY KIOXIA

Pushing the boundaries of what's possible

The future of high-density flash memory.



UPLIFTING THE WORLD WITH "MEMORY"

In 1987 KIOXIA introduced a new technology that has forever changed the way we live, work and play: NAND flash memory

As the inventor of the first flash memory, KIOXIA has been leading a new era by providing advanced memory solutions to enrich people's lives.

Back in 1987, it would have been hard to imagine all of the ways that this brand-new technology would impact the world. NAND flash memory has introduced an entire new technological era. New applications, such as smartphones, tablets and notebooks, automotive infotainment systems, gaming, wearables, data centers and so much more, have been developed that would not exist in the form they are today without this flash memory technology.

From the invention of flash memory to today's renowned BiCS FLASH™, KIOXIA continues to pioneer innovative memory solutions with high quality and reliability. The company's BiCS FLASH™ 3D flash memory technology is an important component in almost all electronic devices where data needs to be stored.

By evolving "memory", KIOXIA creates uplifting experiences and changes the world.

The Evolution of Applications – From Then to Now

Some of the first flash applications are almost unrecognizable today. And, many new applications have been born that would not have been possible without KIOXIA's invention.

THE EARLIEST USERS OF FLASH -IN THE 1990S:

FLASH

TODAY:

APPLICATIONS



Cloud/Edge

Computing





Gaming/

AR/VR





Industrial

Automation





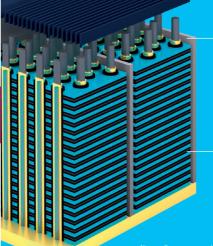




Security/

Surveillance ... and so much more





gen. 2: 48-layer gen. 3: 64-layer

Bit Line

Word Line

Layers of

BICS FLASH™

gen. 8: 218-layer

Embedded Flash Memory

SLC NAND BENAND™

e-MMC **UFS**

> tion for sensitive or frequently used data. **MANAGED NAND**

RAW NAND

For efficient and easy to integrate storage systems, managed NAND like e-MMC and UFS are the preferred solutions. Offering broadly accepted standard interfaces and packages, in combination with high speed interfaces, they are the optimal selection for many application in the industrial, mobile and automotive

KIOXIA offers a wide range of advanced flash memory technology for all kind of applications like consumer electronics, mobile technology and industrial appli-

NAND flash memory requires an appropriate management, which has to cover

tasks like Bad Block Management, Wear Leveling, Garbage Collection and ECC

Error Correction. Either these functions are supported by the host system in

combination with raw NAND memory, or it is covered instantly inside a managed

The selection between these basic different approaches to control a NAND memory defines the individual host requirements and interface options. For

managed NAND there are JEDEC specified Standard-Interfaces supported, ena-

With raw SLC NAND and BENAND™ we provide high endurance and data reten-

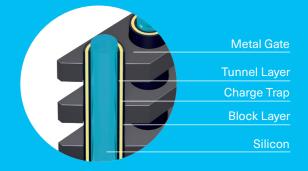
bling the developer to easily design the required memory solution.

NAND by utilizing an integrated memory controller.

3D-TLC

Our BiCS FLASH™ 3D flash memory technology with 64-, 96-, 112-, 162-, 218-layer stacking make a powerful memory solutions possible. It gives BiCS FLASH™ far higher die area density compared to 2D NAND. BiCS FLASH™ reduces the chip size by optimizing both circuit technology and the manufacturing process.

As a result, this technology can achieve similar reliability as 2D-MLC (2bit/cell) while utilizing 3D-TLC (3bit/cell) structure.





KIOXIA 3D-Technology BICS FLASH™

Digital telephone Digital MP3 Personal Digital Barcode Scanners Cameras Players Assistants SSD SSDs Tablets and Automotive Smart Homes/ Smartphones Notebooks **Buildings/Cities**

Wearables &

Digital Health



BENANDTM

SLC NAND with embedded ECC

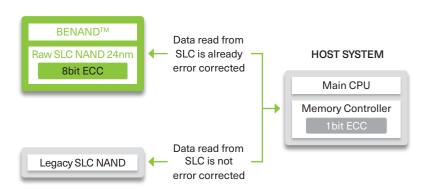
BENAND™ (Built-in ECC NAND) is a SLC NAND memory device which has an internal hardware ECC engine.

Using BENAND™ it is possible for customers to use the 24nm SLC NAND flash memory technology even when their platform cannot support higher bit ECC.

SPECIFICATIONS

FEATURES	BENAND™ (SLC+ECC)
Density	1 Gbit – 8 Gbit
Technology	2D-SLC
ECC (Error Correction Code)	Embedded on Memory Chip
Temperature	-40° C to 85° C 0° C to 70° C
Package	TSOP and BGA

BENAND™ - SLC WITH EMBEDDED ECC FOR BOM REDUCTION AND SYSTEM FLEXIBILITY



CAPACITIES:









KEY FEATURES:

- 1 Gbit 8 Gbit
- Compatibility of SLC NAND Interface, basic functions and command sequence follows SLC NAND.
- Same hardware interface and package as raw SLC

ADVANTAGES

- · Broad line-up to cover customers' demands for different densities
- 24nm technology for cost optimisation
- · Long data retention or high write/ erase performance
- Small package variation available to reduce board space by 48 % (up to 8 Gbit)
- · With BENAND™ no ECC operation is required on the host side

APPLICATIONS:

- · Industrial Applications
- · Consumer Electronics
- · Multimedia Applications
- · Smart Metering & Intelligent Lighting
- · Smart Applications

KIOXIA •••• ••• ••• ••• 0000000 0000000 SLC NAND ****** 0000000 ******* ********

SLC NAND

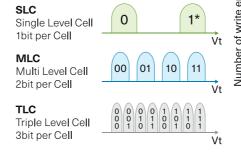
Reliability and Performance

KIOXIA's advanced flash memory technology offers SLC NAND providing best in class endurance and data retention for sensitive or frequently used data in a system. For long lasting products or systems working with extremely high data throughput between the host and the memory, KIOXIA SLC is the optimal solution.

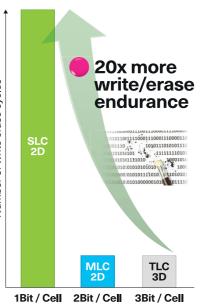
SPECIFICATIONS

FEATURES	SLC NAND
Density	1 Gbit – 256 Gbit
Technology	2D-SLC
ECC (Error Correction Code)	Required on Host Side
Temperature	-40° C to 85° C 0° C to 70° C
Package	TSOP and BGA

Based on the "one bit per cell"-structure, SLC NAND can resist a significant higher number of write erase stress during lifetime than any MLC/TLC based product. This enables the system designer to develop a long lasting and extreme reliable storage solution even in challenging environments or use case scenarios.



^{*} The binary assignment is individual set by each vendor



CAPACITIES:



















KEY FEATURES:

- 1 Gbit 256 Gbit
- Extended temperature range
- TSOP and BGA package

ADVANTAGES

- · Broad line up to cover customers' demands for different densities
- 24nm technology for cost optimisation
- · Long data retention or high write/ erase performance
- Small package variation available to reduce board space by 48 % (up to 8 Gbit)

APPLICATIONS:

- · Industrial Applications
- Consumer Electronics
- · Multimedia Applications
- Smart Metering & Intelligent Lighting
- Smart Applications







e-MMC

Highly-efficient Storage

e-MMC is a family of advanced and highly efficient NAND flash memory with an integrated controller for enhanced memory management. Based on an interface standardised by JEDEC, KIOXIA's e-MMC offers the optimal solution for applications where higher data volumes need to be stored in an efficient way.

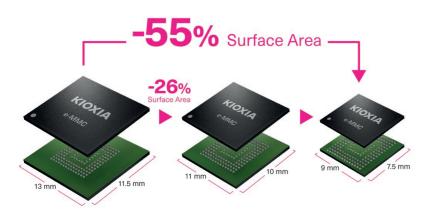
SPECIFICATIONS

FEATURES	e-MMC	EXTENDED TEMP. e-MMC			
Density	4 GB – 128 GB	8 GB – 128 GB			
Technology	2D-MLC / 3D-TLC	2D-MLC / 3D-TLC			
JEDEC Version	5.0 / 5.1	5.1			
Temperature	-25°C to 85°C	-40°C to 105°C			
Package	153 ball FBGA (11.5 x 13 mm)				

e-MMC - UTILIZING BiCS FLASH™

With the innovative BiCS FLASHTM 3D flash memory technology in combination with the new charge trap cell structure, Kioxia continuously provide the best-in-class family of reliable, easy to integrate, and efficient e-MMCs. These new e-MMCs represent an attractive alternative with superior price competitiveness, longevity, and higher performance.

4GB e-MMC available in 3 package sizes with same ball arrangement



CAPACITIES:







128 GB





KEY FEATURES:

- 4 GB 128 GB
- 2D-MLC / 3D-TLC technology
- e-MMC Version 5.0 and 5.1
- · Integrated memory management:
- Error correction code
- Bad block management
- Wear-levelling
- Garbage collection
- Standard and extended temperature range of up to 105°C
- FBGA package

ADVANTAGES

- Higher interface speed HS400 in accordance with JEDEC 5.x
- Managed memory
- Package, interface, features, commands, etc. are standard

APPLICATIONS:

- Industrial Applications
- Consumer Electronics
- Multimedia Applications
- Smart Metering & Intelligent Lighting
- Smart Applications

UFS

High Performance Storage

For applications demanding for superior interface performance, KIOXIA is offering a broad line-up of new UFS memory products. Utilizing a full duplex serial high-speed interface, it is compliant with the latest UFS Version 3.1 and 4.0. In combination with the embedded memory management, it offers a highly efficient and excellent performing storage solution. UFS memory enables next generation mobile devices to take full advantage of the connectivity benefits of 5G, leading to faster downloads and reduced lag time – and improved user experience.

KIOXIA

UFS

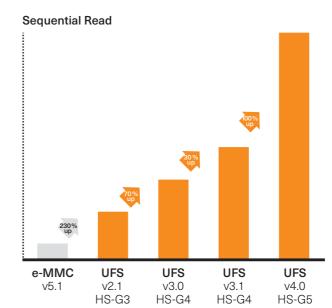
SPECIFICATIONS

FEATURES	UFS - UNIVERSAL FLASH STORAGE
Density	128 GB – 1 TB
Technology	3D-TLC
JEDEC Version	3.1 and 4.0
Temperature	-25° C to 85° C
Package	153 ball FBGA (11.5 x 13 mm and 11 x 13 mm)

COMPARING THE PERFORMANCE:

FLASH MEMORY





CAPACITIES:









KEY FEATURES:

- 128 GB 1 TB
- BiCS FLASH™
- 3D-TLC technology
- UFS Version 3.1 and 4.0
- Integrated memory management:
- _____
- Error correction code
- Bad block management
- Wear-levelling
- Garbage collection
- WriteBooster: Enables significantly faster write speeds
- Standard temperature range up to 85°C
- FBGA package
- High Speed Serial interface

ADVANTAGES

- High speed interface up to 1160 MB/ sec / 2320 MB/sec / 4640 MB/sec
- Managed memory
- Package, interface, features, commands, etc. are standard
- Utilises high quality KIOXIA BiCS FLASH™ memory in combination with a KIOXIA origin developed controller

APPLICATIONS:

- · Consumer Electronics
- Multimedia Applications
- Smart Applications











e-MMC Automotive

e-MMC for Automotive Demands

E-mobility, autonomous driving, higher demands on safety and sustainability – automotive industries are once more leading in innovation and technology. For these smart and connected vehicles, reliable storage solutions are mandatory. KIOXIA provides one of the key technologies for wireless communication, information systems and Advanced Driver Assistance Systems (ADAS).

			l					
DENSITY	PART NUMBER	JEDEC	POWER SUPPLY VOLTAGE		TEMPERATURE	PACKAGE		
DLINGITI	FART NOIVIBLE	VERSION	VCC (V)	VCCQ (V)	TEWFERATORE	FACRAGE		
8 GB	THGBMJG6C1LBAC7							
16 GB	THGBMJG7C2LBAC8	e-MMC 5 1	2.7 – 3.6	1.7 – 1.95	-40°C to 105°C (Automotive			
32 GB	THGBMJG8C4LBAC8	e-iviivio 5.1	2.7 - 3.0	2.7 – 3.6	Grade 2)			
64 GB	THGBMJG9C8LBAC8							
32 GB	THGAMVG8T13BAA7	e-MMC 5.1			-40°C to 85°C			
64 GB	THGAMVG9T23BAA8		e-MMC 5.1	e-MMC 5.1		1.7 – 1.95	(Automotive	FBGA153
128 GB	THGAMVT0T43BAA8					Grade 3)	1 BGA133	
256 GB	THGAMVT1T83BAA5							
32 GB	THGAMVG8T13BAB7							
64 GB	THGAMVG9T23BAB8	e-MMC 5.1	2.7 – 3.6	1.7 – 1.95	-40°C to 105°C			
128 GB	THGAMVT0T43BAB8		2.7 - 3.0	1.7 - 1.95	(Automotive Grade 2)			
256 GB	THGAMVT1T83BAB5							

ADAS DOMAIN

CONTROLLER

CAPACITIES:







256





AEC-Q100 qualified

KEY FEATURES:

- Compliant with IATF16949
- Temperature range:
 Automotive Grade 2 & Grade 3
 (-40° C ~ +105° C & -40° C ~ +85° C)
- Compliant with e-MMC 5.1
- Highly reliable technology 2D-MLC and 3D-TLC
- Integrated memory management:
- Error correction code
- Bad block management
- Wear-levelling

GATEWAY DOMAIN

CONTROLLER

COCKPIT DOMAIN

CONTROLLER

mple of NAND flash storage uses

- Garbage collection
- Automotive specific functions

GATEWAY

TELEMATICS

NAVIGATION

IN-VEHICLE INFOTAINMENT

DIGITAL INSTRUMENT CLUSTER

REAR SEAT ENTERTAINMENT

UFS Automotive

KIOXIA

Automotive

UFS

UFS for Automotive Demands

Accelerated processing power and increased data storage capacity are the keys to enabling the next generation of automotive systems. For applications demanding for superior interface performance, KIOXIA is offering a line-up of new UFS automotive memory products. Utilizing a full duplex serial high-speed interface, it is compliant with the UFS Version 3.1 and 4.0.

PART NUMBER	JEDEC	JEDEC POWER SUPPLY VOLTAGE VERSION VCC (V) VCCQ (V)		TEMPERATURE	PACKAGE	
PART NUMBER	VERSION			TEIVIPERATURE	TACKAGE	
THGJFGG9T15BAA8						
THGJFGT0T25BAA8	LIEC 2.1	2.4 – 2.7	1.14 to	-40° C to 85° C	FBGA153	
THGJFGT1T45BAA8	053.1	2.7 – 3.6	1.26	Grade 3)	FBGAISS	
THGJFGT2T85BAA5						
THGJFGG9T15BAB8						
THGJFGT0T25BAB8	UFS 3.1	JFS 3.1 2.4 – 2.7 2.7 – 3.6	1.14 to 1.26	-40° C to 105° C (Automotive Grade 2)	FBGA153	
THGJFGT1T45BAB8						
THGJFGT2T85BAB5						
THGJFJT0T25BAA8	UFS4.0				-40° C to 85° C	
THGJFJT1T45BAA8		2.4 – 2.7	1.14 to 1.26	(Automotive	FBGA153	
THGJFJT2T85BAA5			1.20	Grade 3)		
THGJFJT0T25BAB8				-40°C to 105°C (Automotive Grade 2)	FBGA153	
THGJFJT1T45BAB8	UFS4.0	2.4 – 2.7	1.14 to 1.26			
THGJFJT2T85BAB5						
	THGJFGT0T25BAA8 THGJFGT1T45BAA5 THGJFGG9T15BAB8 THGJFGT0T25BAB8 THGJFGT1T45BAB8 THGJFGT1T45BAB5 THGJFGT2T85BAB5 THGJFJT0T25BAA8 THGJFJT1T45BAA8 THGJFJT0T25BAA8 THGJFJT1T45BAA8 THGJFJT1T45BAB8	THGJFGG9T15BAA8 THGJFGT0T25BAA8 THGJFGT1T45BAA8 THGJFGT2T85BAA5 THGJFGT0T25BAB8 THGJFGT0T25BAB8 THGJFGT1T45BAB8 THGJFGT2T85BAB5 THGJFJT0T25BAA8 THGJFJT0T25BAA8 THGJFJT0T25BAA8 THGJFJT0T25BAA8 THGJFJT1T45BAA8 THGJFJT0T25BAB8 THGJFJT0T25BAB8 THGJFJT0T25BAB8 THGJFJT0T25BAB8	THGJFGG9T15BAA8 THGJFGT1T45BAA8 THGJFGT2T85BAA5 THGJFGT0T25BAB8 THGJFGT0T25BAB8 THGJFGT1T45BAB8 THGJFGT2T85BAB5 THGJFGT2T85BAB5 THGJFGT2T85BAB5 THGJFJT0T25BAA8 THGJFJT0T25BAA8 THGJFJT0T25BAA8 THGJFJT1T45BAA8 THGJFJT1T45BAB8 THGJFJT1T45BAB8 THGJFJT1T45BAB8 THGJFJT1T45BAB8 THGJFJT1T45BAB8	THGJFGG9T15BAA8 THGJFGT1T45BAA8 THGJFGT2T85BAA5 THGJFGT0T25BAB8 THGJFGT0T25BAB8 THGJFGT1T45BAB8 THGJFGT1T45BAB8 THGJFGT1T45BAB8 THGJFGT1T45BAB8 THGJFJT0T25BAA8 THGJFJT0T25BAA8 THGJFJT0T25BAA8 THGJFJT0T25BAA8 THGJFJT0T25BAB8 THGJFJT1T45BAB8 THGJFJT1T45BAB8 THGJFJT1T45BAB8 THGJFJT1T45BAB8 THGJFJT1T45BAB8 THGJFJT1T45BAB8 THGJFJT1T45BAB8	THGJFGG9T15BAA8 THGJFGT1T45BAA8 THGJFGT2T85BAA5 THGJFGT2T85BAA5 THGJFGT0T25BAB8 THGJFGT1T45BAB8 THGJFGT1T45BAB8 THGJFGT2T85BAB5 THGJFGT2T85BAB5 THGJFGT1T45BAB8 THGJFGT2T85BAB5 THGJFJT1T45BAB8	

CAPACITIES:







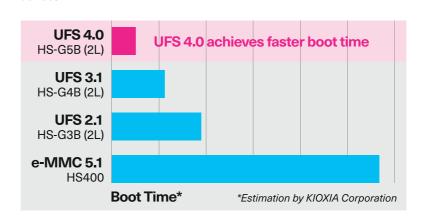


KEY FEATURES:

- AEC-Q100 qualified
- Compliant with IATF16949
- Temperature range:
- Automotive Grade 3 (-40°C ~ +85°C)
- Automotive Grade 2 (-40 $^{\circ}$ C \sim +105 $^{\circ}$ C)
- Highly reliable technology 3D-TLC
- Compliant with UFS 3.1 / 4.0
- Integrated memory management:
- Error correction code
- Bad block management
- Wear-levellingGarbage collection
- Automotive specific functions

Quick System Start Up

KIOXIA UFS 4.0 automotive devices use HS-LSS (High Speed Link Startup Sequence) to achieve a faster boot time when compared to previous generation devices.





INTELLIGENT DRIVER ASSISTANTS

IMAGE RECOGNITION

ROUTE DECISION

EVENT DATA RECORDER

AUTONOMOUS DRIVING

SPECIFICATIONS 14

Product List

SLC NAND

DENSITY	PART NUMBER	TECHN.	PAGE SIZE	VCC	ECC	TEMPERATURE	PACKAGE
	TC58NVG0S3HTA00		(2048+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58NYG0S3HBAI4		(2048+128) x 8 bit	1.8V		-40° C to 85° C	63BGA 9 x 11
	TC58NVG0S3HTAI0	00.010	(2048+128) x 8 bit	3.3V	01 : /= . 05	-40° C to 85° C	48TSOP 12 x 20
1 Gbit	TC58NVG0S3HBAI4	2D-SLC	(2048+128) x 8 bit	3.3V	8bit/512B	-40° C to 85° C	63BGA 9 x 11
	TC58NYG0S3HBAI6		(2048+128) x 8 bit	1.8V		-40° C to 85° C	67BGA 6.5 x 8
	TC58NVG0S3HBAI6		(2048+128) x 8 bit	3.3V		-40° C to 85° C	67BGA 6.5 x 8
	TC58NVG1S3HTA00		(2048+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58NYG1S3HBAI4		(2048+128) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
2 Gbit	TC58NVG1S3HTAI0	2D-SLC	(2048+128) x 8 bit	3.3V	8bit/512B	-40°C to 85°C	48TSOP 12 x 20
2 GDIT	TC58NVG1S3HBAI4	2D-8LC	(2048+128) x 8 bit	3.3V	8011/5128	-40°C to 85°C	63BGA 9 x 11
	TC58NYG1S3HBAI6		(2048+128) x 8 bit	1.8V		-40°C to 85°C	67BGA 6.5 x 8
	TC58NVG1S3HBAI6		(2048+128) x 8 bit	3.3V		-40°C to 85°C	67BGA 6.5 x 8
	TH58NVG2S3HTA00		(2048+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58NVG2S0HTA00		(4096+256) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58NVG2S0HTAI0		(4096+256) x 8 bit	3.3V		-40°C to 85°C	48TSOP 12 x 20
	TH58NVG2S3HTAI0		(2048+128) x 8 bit	3.3V		-40°C to 85°C	48TSOP 12 x 20
4 Gbit	TH58NVG2S3HBAI4	2D-SLC	(2048+128) x 8 bit	3.3V	8bit/512B	-40°C to 85°C	63BGA 9 x 11
4 GDIL	TH58NYG2S3HBAI4	2D-3LC	(2048+128) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
	TC58NVG2S0HBAI4		(4096+256) x 8 bit	3.3V		-40°C to 85°C	63BGA 9 x 11
	TC58NYG2S0HBAI4		(4096+256) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
	TC58NVG2S0HBAI6		(4096+256) x 8 bit	3.3V		-40°C to 85°C	67BGA 6.5 x 8
	TC58NYG2S0HBAI6		(4096+256) x 8 bit	1.8V		-40°C to 85°C	67BGA 6.5 x 8
	TH58NVG3S0HTA00		(4096+256) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TH58NVG3S0HBAI4		(4096+256) x 8 bit	3.3V		-40° C to 85° C	63BGA 9 x 11
8 Gbit	TH58NYG3S0HBAI4	2D-SLC	(4096+256) x 8 bit	1.8V	8bit/512B	-40° C to 85° C	63BGA 9 x 11
6 GDIL	TH58NVG3S0HTAI0		(4096+256) x 8 bit	3.3V	6DIL/512D	-40° C to 85° C	48TSOP 12 x 20
	TH58NVG3S0HBAI6		(4096+256) x 8 bit	3.3V		-40° C to 85° C	67BGA 6.5 x 8
	TH58NYG3S0HBAI6		(4096+256) x 8 bit	1.8V		-40° C to 85° C	67BGA 6.5 x 8
16 Gbit	TH58NVG4S0HTA20	2D-SLC	(4096+256) x 8 bit	3.3V	8bit/512B	0°C to 70°C	48TSOP 12 x 20
10 abit	TH58NVG4S0HTAK0	2D-0L0	(4096+256) x 8 bit	3.3V	0bit/ 512b	-40° C to 85° C	48TSOP 12 x 20
32 Gbit	TC58NVG5H2HTA00	2D-SLC	(8192+1024) x 8 bit	3.3V	24bit/1024B	0°C to 70°C	48TSOP 12 x 20
32 dbit	TC58NVG5H2HTAI0	2D-0L0	(8192+1024) x 8 bit	3.3V	24017 10240	-40°C to 85°C	48TSOP 12 x 20
	TH58NVG6H2HTAK0		(8192+1024) x 8 bit	3.3V		-40°C to 85°C	48TSOP 12 x 20
64 Gbit	TH58TEG6H2HBAMC	2D-SLC	(8192+1024) x 8 bit	3.3V	24bit/1024B	-40°C to 85°C	132BGA 12 x 18
04 abit	TH58NVG6H2HTA20	LD OLO	(8192+1024) x 8 bit	3.3V	ZHDIQ TOZHD	0°C to 70°C	48TSOP 12 x 20
	TH58TEG6H2HBA4C		(8192+1024) x 8 bit	3.3V		0°C to 70°C	132BGA 12 x 18
	TH58NVG7H2HTAK0		(8192+1024) x 8 bit	3.3V		-40°C to 85°C	48TSOP 12 x 20
128 Gbit	TH58TEG7H2HBASC	2D-SLC	(8192+1024) x 8 bit	3.3V	24bit/1024B	-40°C to 85°C	132BGA 12 x 18
120 abit	TH58NVG7H2HTA20	20 020	(8192+1024) x 8 bit	3.3V	2 1010 10270	0°C to 70°C	48TSOP 12 x 20
	TH58TEG7H2HBA8C		(8192+1024) x 8 bit	3.3V		0°C to 70°C	132BGA 12 x 18
256 Gbit	TH58TEG8H2HBA89	2D-SLC	(8192+1024) x 8 bit	3.3V	24bit/1024B	0°C to 70°C	132BGA 12 x 18
200 GDIT	TH58TEG8H2HBAS9	2D-SLC	(8192+1024) x 8 bit	3.3V	24010/10240	-40°C to 85°C	132BGA 12 x 18

Product List

BENAND™

DENSITY	PART NUMBER	TECHN.	PAGE SIZE	VCC	ECC	TEMPERATURE	PACKAGE
	TC58BVG0S3HTA00		(2048+64) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
1 Gbit	TC58BYG0S3HBAI4		(2048+64) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
	TC58BVG0S3HTAI0	2D-SLC	(2048+64) x 8 bit	3.3V	:	-40°C to 85°C	48TSOP 12 x 20
	TC58BVG0S3HBAI4		(2048+64) x 8 bit	3.3V	internal ECC	-40°C to 85°C	63BGA 9 x 11
	TC58BYG0S3HBAI6		(2048+64) x 8 bit	1.8V		-40°C to 85°C	67BGA 6.5 x 8
	TC58BVG0S3HBAI6		(2048+64) x 8 bit	3.3V		-40°C to 85°C	67BGA 6.5 x 8
	TC58BVG1S3HTA00		(2048+64) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58BYG1S3HBAI4		(2048+64) x 8 bit	1.8V		-40°C to 85°C	63BGA 9 x 11
2 Gbit	TC58BVG1S3HTAI0	2D-SLC	(2048+64) x 8 bit	3.3V	internal ECC	-40°C to 85°C	48TSOP 12 x 20
2 GDIL	TC58BVG1S3HBAI4	ZD-SLC	(2048+64) x 8 bit	3.3V	Internal ECC	-40°C to 85°C	63BGA 9 x 11
	TC58BYG1S3HBAI6		(2048+64) x 8 bit	1.8V		-40°C to 85°C	67BGA 6.5 x 8
	TC58BVG1S3HBAI6		(2048+64) x 8 bit	3.3V		-40°C to 85°C	67BGA 6.5 x 8
	TH58BVG2S3HTA00		(2048+64) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58BVG2S0HTA00		(4096+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TC58BVG2S0HTAI0		(4096+128) x 8 bit	3.3V		-40°C to 85°C	48TSOP 12 x 20
	TH58BVG2S3HTAI0		(2048+64) x 8 bit	3.3V		-40°C to 85°C	48TSOP 12 x 20
	TH58BVG2S3HBAI4		(2048+64) x 8 bit	3.3V		-40°C to 85°C	63BGA 9 x 11
4 Gbit	TH58BYG2S3HBAI4	2D-SLC	(2048+64) x 8 bit	1.8V	internal ECC	-40°C to 85°C	63BGA 9 x 11
	TC58BVG2S0HBAI4		(4096+128) x 8 bit	3.3V		-40° C to 85° C	63BGA 9 x 11
	TC58BYG2S0HBAI4		(4096+128) x 8 bit	1.8V		-40° C to 85° C	63BGA 9 x 11
	TC58BVG2S0HBAI6		(4096+128) x 8 bit	3.3V		-40° C to 85° C	67BGA 6.5 x 8
	TC58BYG2S0HBAI6		(4096+128) x 8 bit	1.8V		-40° C to 85° C	67BGA 6.5 x 8
	TH58BYG2S3HBAI6		(2048+64) x 8 bit	1.8V		-40° C to 85° C	67BGA 6.5 x 8
	TH58BVG3S0HTA00		(4096+128) x 8 bit	3.3V		0°C to 70°C	48TSOP 12 x 20
	TH58BYG3S0HBAI4		(4096+128) x 8 bit	1.8V		-40° C to 85° C	63BGA 9 x 11
8 Gbit	TH58BVG3S0HTAI0	2D-SLC	(4096+128) x 8 bit	3.3V	internal ECC	-40°C to 85°C	48TSOP 12 x 20
8 GDI	TH58BVG3S0HBAI4	ZD-SLC	(4096+128) x 8 bit	3.3V	internal ECC	-40°C to 85°C	63BGA 9 x 11
	TH58BVG3S0HBAI6		(4096+128) x 8 bit	3.3V		-40°C to 85°C	67BGA 6.5 x 8
	TH58BYG3S0HBAI6		(4096+128) x 8 bit	1.8V		-40°C to 85°C	67BGA 6.5 x 8

e-MMC

DENSITY	PART NUMBER	TECHN.	VCCQ	JEDEC VERSION	TEMPERATURE	PACKAGE
	THGBMNG5D1LBAIK		1.8V or 3.3V	e-MMC 5.0	-25°C to 85°C	153FBGA 7,5 x 9
4 GB	THGBMNG5D1LBAIT	2D-MLC			-25°C to 85°C	153FBGA 11 x 10
	THGBMTG5D1LBAIL				-25°C to 85°C	153FBGA 11.5 x 13
8 GB	THGBMUG6C1LBAIL	2D-MLC	1.8V or 3.3V	e-MMC 5.1	-25°C to 85°C	153FBGA 11.5 x 13
6 GB	THGBMJG6C1LBAU7	ZD-IVILO	1.00 01 3.30		-40°C to 105°C	153FBGA 11.5 x 13
16 GB	THGBMJG7C2LBAU8	2D-MLC	1.8V or 3.3V	e-MMC 5.1	-40°C to 105°C	153FBGA 11.5 x 13
10 00	THGAMVG7T13BAIL	3D-TLC	1.8V		-25°C to 85°C	153FBGA 11.5 x 13
	THGBMJG8C4LBAU8	2D-MLC	1.8V or 3.3V	e-MMC 5.1	-40°C to 105°C	153FBGA 11.5 x 13
32 GB	THGAMVG8T13BAU7	3D-TLC	1.8V		-40°C to 105°C	153FBGA 11.5 x 13
	THGAMVG8T13BAIL	30-110	1.00		-25°C to 85°C	153FBGA 11.5 x 13
64 GB	THGAMVG9T23BAU8	3D-TLC 1.8V	1.8V	e-MMC 5.1	-40°C to 105°C	153FBGA 11.5 x 13
04 GB	THGAMSG9T15BAIL	3D-1LO	1.07	e-WINO 3.1	-25°C to 85°C	153FBGA 11.5 x 13
128 GB	THGAMST0T25BAIL	25BAIL 3D-TLC 1.8V	e-MMC 5.1	-25°C to 85°C	153FBGA 11.5 x 13	
120 00	THGAMVT0T43BAU8	3D TLO	1.0 V	6-IVIIVIO 5. I	-40°C to 105°C	153FBGA 11.5 x 13
256 GB	THGAMVT1T83BAU5	3D-TLC	1.8V	e-MMC 5.1	-40°C to 105°C	153FBGA 11.5 x 13

UFS

DENSITY	PART NUMBER	TECHN.	VCC VCCQ (3.X)	JEDEC VERSION	TEMPERATURE	PACKAGE
128 GB	THGJFJT0E25BAIP	3D-TLC	2.5V 1.2V	UFS 4.0	-25°C to 85°C	153FBGA 11 x 13
256 GB	THGJFGT1E45BAIP	3D-TLC 2.5V 1.2V	2.5V 1.2V	UFS 3.1	-25° C to 85° C	153FBGA 11 x 13
250 GB	THGJFLT1E45BATP	3D-1LC	2.50 1.20	UFS 4.0		153FBGA 11 x 13
512 GB	THGJFGT2T85BAIU	3D-TLC	UFS 3.1	-25°C to 85°C	153FBGA 11 x 13	
512 GB	THGJFLT2E46BATP	2.5V 1.2V	UFS 4.0	-25 C t0 65 C	153FBGA 11 x 13	
1 TB	THGJFLT3E86BATU	3D-TLC	2.5V 1.2V	UFS 4.0	-25°C to 85°C	153FBGA 11 x 13







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